

Notice of References Cited	Application/Control No. 10/509,484	Applicant(s)/Patent Under Reexamination ITO ET AL.	
	Examiner Olga N. Chernyshev	Art Unit 1649	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Skolnick et al., 2000, TIBTECH, Vol. 18, pp. 34-39.
	V	Yan et al. 2000, Science, Vol. 290, pp.523-527.
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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